 Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/895,434	REED ET AL.	
Examiner	Art Unit	
Jude J. Jean-Gilles	2143	

	SEAR	CHED	
Class	Subclass	Date	Examiner
709	223 204 208 223	7/22/2006	JG
707	10	7/22/2006	JG
714	1 2 37	7/22/2006	JG
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH N)
	DATE	EXMR
PAM tool: Effective Filing Date Double Patenting	7/22/2006	JG
EAST tool: DERWENT USPAT EPO JPO	7/22/2006	JG
Internet : google.com onelook.com NPLs IEEE	7/22/2006	JG
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